

**Search Notes**

Application/Control No.

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Examiner

John Chavis

Applicant(s)/Patent under  
Reexamination

TAKAYAMA ET AL.

Art Unit

2191

**SEARCHED**

Class	Subclass	Date	Examiner
717	151	6/27/2005	JC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
717	151	6/27/2005	JC

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
West (IBM TDB, EPO, JPO, PGPUBS, USPAT, DERWENT)	6/27/2005	JC
Inventor Search for Double Patenting	6/27/2005	JC